TOSHIBA MT3S03AS

TENTATIVE

TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL PLANAR TYPE

*1*13503AS

VHF~UHF BAND LOW NOISE AMPLIFIER APPLICATIONS

Unit in mm

Low Noise: Figure: NF = 1.4 dB

High Gain : Gain = 8 dB (f = 2 GHz)

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	v_{CBO}	10	V
Collector-Emitter Voltage	v_{CEO}	5	V
Emitter-Base Voltage	$V_{ m EBO}$	2	V
Base Current	$I_{\mathbf{C}}$	40	mA
Collector Current	$I_{\mathbf{B}}$	10	mA
Collector Power Dissipation	PC	100	mW
Junction Temperature	T_{j}	125	°C
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~125	$^{\circ}\mathrm{C}$

1.6 ± 0.2 0.8 ± 0.1 0+0 BASE 2. EMITTER COLLECTOR SSM **JEDEC EIAJ** TOSHIBA 2-2H1A

MARKING



MICROWAVE CHARACTERISTICS (Ta = 25°C)

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CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
I'I'rangition E'reguency ——	f _T (1)	$V_{CE} = 1 V$, $I_{C} = 5 mA$	3	5	_	GHz
	f _T (2)	$V_{CE} = 3 V, I_{C} = 10 mA$	7	10		
Insertion Gain	$ S_{21e} ^2$ (1)	$V_{ ext{CE}} = 1 \text{ V}, \text{ I}_{ ext{C}} = 5 \text{ mA},$ $f = 2 \text{ GHz}$	1	5.5	l	dB
		$V_{CE} = 3 \text{ V}, I_{C} = 20 \text{ mA}, $ f = 2 GHz	6	8	_	
Noise Figure	NF (1)	$V_{ ext{CE}} = 1 \text{ V}, \text{ I}_{ ext{C}} = 5 \text{ mA},$ $f = 2 \text{ GHz}$	_	1.7	3	dB
	NF (2)	$V_{\text{CE}} = 3 \text{ V}, \text{ I}_{\text{C}} = 7 \text{ mA},$ $f = 2 \text{ GHz}$	_	1.4	2.2	uD

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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	I_{CBO}	$V_{CB} = 5 V, I_{E} = 0$	_	_	0.1	μ A
Emitter Cut-off Current	${ m I}_{ m EBO}$	$V_{EB} = 1 V, I_{C} = 0$	_	_	1	μ A
DC Current Gain	$_{ m h_{FE}}$	$V_{CE} = 1 \text{ V}, I_{C} = 5 \text{ mA}$	80	_	160	_
Reverse Transfer Capacitance	c_{re}	$V_{CB} = 1 \text{ V}, I_{E} = 0, f = 1 \text{ MHz}$ (Note)	_	0.75	1.1	pF

(Note): C_{re} is measured by 3 terminal method with capacitance bridge.

CAUTION

This device electrostatic sensitivity. Please handle with caution.